

Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE	ATTY DOCKET NO. 117243	APPLICATION NO. 10/690,270		
INFORMATION DISCLOSURE STATEMENT <small>(Use several sheets if necessary)</small>		APPLICANT(S) Yuichi SHIMIZU et al.				
		FILING DATE October 22, 2003	GROUP 2871			
U.S. PATENT DOCUMENTS						
Examiner Initials	Cite No.	Document Number	Date	Name		
FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation
1	1	JP-A-2000-094072	03/29/2002	Japan	X	X
✓	2	JP-A-05-129333	05/25/1993	Japan	X	X
✓	3	JP-A-04-022127	01/27/1992	Japan	X	
✓	4	JP-A-2001-066638	03/16/2001	Japan	X	X
OTHER DOCUMENTS						
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)				
EXAMINER				DATE CONSIDERED <i>04-02-06</i>		
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Sheet 1 of 1

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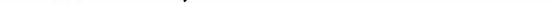
U.S. PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation
M	1	JP-A 2000-10120	01/14/2000	Japan	X	X
N	2	JP-A 2002-57341	02/22/2002	Japan	X	x

OTHER DOCUMENTS

Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER		DATE CONSIDERED <u>7/7/04</u>
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Date: May 3, 2006